

<b>Notice of References Cited</b>	Application/Control No. 10/024,849		Applicant(s)/Patent Under Reexamination PUCHEU-MARQUE, GERAD	
	Examiner VENKATESH HALIYUR		Art Unit 2619	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,073,005	06-2000	Raith et al.	455/404.1
*	B	US-6,633,754	10-2003	Raith, Alex K.	455/404.1
*	C	US-6,961,329	11-2005	Bender et al.	370/342
*	D	US-6,477,362	11-2002	Raith et al.	455/404.1
*	E	US-6,115,596	09-2000	Raith et al.	455/404.2
*	F	US-5,845,215	12-1998	Henry et al.	455/426.1
*	G	US-5,787,076	07-1998	Anderson et al.	370/294
*	H	US-6,130,886	10-2000	Ketseoglou et al.	370/347
*	I	US-6,625,132	09-2003	Boettger et al.	370/329
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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